

Search Notes

Application/Control No.

10/812,627

Examiner

Marie Patterson

Applicant(s)/Patent under
Reexamination

CHEN, EDDIE

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
036	4, 12	1/31/2006	<i>MDP</i>
	14, 10		
	55, 21		
	43, 44		
	17R		
036	17PW	1/31/2006	<i>MDP</i>
<hr/>			
<i>Updated</i>		<i>6/27/06</i>	<i>MDP</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>East Text</i>		<i>6/24/06</i>	<i>MDP</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR